

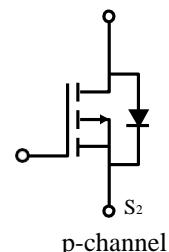
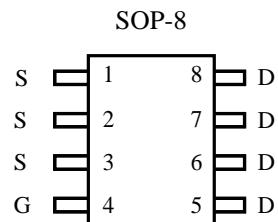
P-Channel High Density Trench MOSFET

Features:

- Super high dense cell trench design for low $R_{DS(on)}$.
- Rugged and reliable.
- Improved Shoot-Through FOM.
- Surface Mount package.

PRODUCT SUMMARY

V_{DSS}	I_D	$R_{DS(on)}(m\Omega)$ Max
$-30V$	- 7.5A	50 @ $V_{GS} = -10V$
	- 4.5A	62 @ $V_{GS} = -4.5V$



KSC4485□P
 └─ Package Type : SOP-8
 └─ F : Pb Free
 └─ G : Green (Halogen Free)

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	- 30	V
Gate-Source Voltage	V_{GS}	± 25	V
Drain Current-Continuous ^a @ $T_A = 25^\circ C$ -Pulse ^b	I_D	- 7.5	A
	I_{DM}	- 28	A
Drain-Source Diode Forward Current ^a	I_S	- 1.9	A
Maximum Power Dissipation ^a	P_D	2.5	W
		1.5	
Operating Junction and Storage Temperature Range	T_J, T_{STG}	- 55 to 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance,Junction-to-Ambient ^a	R_{thJA}	50	°C/W
---	------------	----	------

Note:

a. Surface Mounted on FR4 Board , $t \leq 10sec$.

b. Pulse width limited by maximum junction temperature .



ELECTRICAL CHARACTERISTICS (T_A = 25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ ^c	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BVDSS	V _{GS} = 0V , I _D = -250uA	-30			V
Zero Gate Voltage Drain Current	Idss	V _{DS} = -24V , V _{GS} = 0V		-1		uA
Gate-Body Leakage	I _{GSS}	V _{GS} = -20V , V _{DS} = 0V		-100		nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = -250uA	-1	-1.5	-3	V
Drain-Source On-State Resistance	R _{DSS(on)}	V _{GS} = -10V , I _D = -5.5A		38	50	mΩ
		V _{GS} = -4.5V , I _D = -4.2A		50	62	mΩ
Forward Transconductance	g _{fs}	V _{DS} = -15V , I _D = -5.3A		12		S
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode Forward Voltage	V _{SD}	V _{GS} = 0V , I _S = -5.3A			-1.2	V
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{iss}	V _{DS} = -15V , V _{GS} = 0V f = 1.0MHz		796		pF
Output Capacitance	C _{oss}			119		pF
Reverse Transfer Capacitance	C _{rss}			97		pF
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{D(ON)}	V _{DD} = -15V , I _D = -3A V _{GEN} = -10V R _L = 5 Ω R _{GEN} = 6 Ω		9.2		ns
Rise Time	t _r			5.2		ns
Turn-Off Delay Time	t _{D(OFF)}			41.5		ns
Fall Time	t _f			12.8		ns
Total Gate Charge	Q _g			18.6		nC
Gate-Source Charge	Q _{gs}	V _{DS} = -15V I _D = -3A V _{GS} = -10V		3.5		nC
Gate-Drain Charge	Q _{gd}			2.3		nC

Note:

b. Pulse Test: Pulse width ≤ 300us , Duty Cycle ≤ 2% .

c. Guaranteed by design , not subject to production testing .

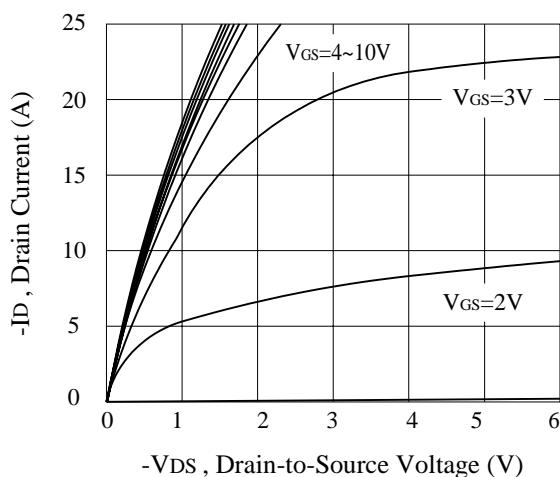


Figure 1. Output Characteristics

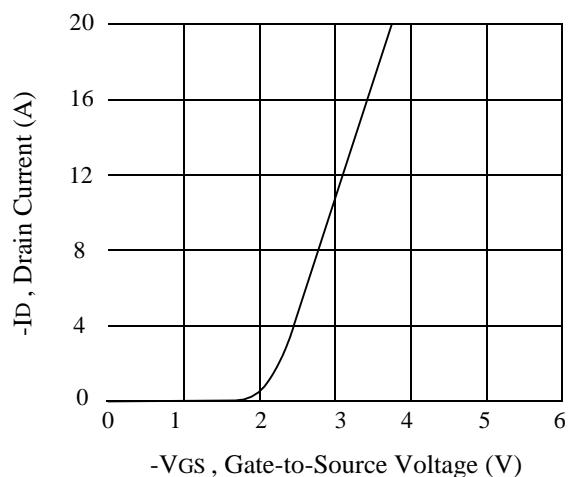


Figure 2. Transfer Characteristics

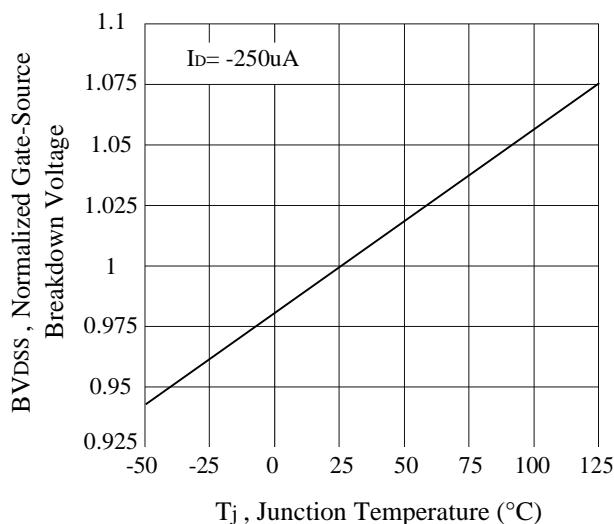


Figure 3. Breakdown Voltage Variation with Temperature

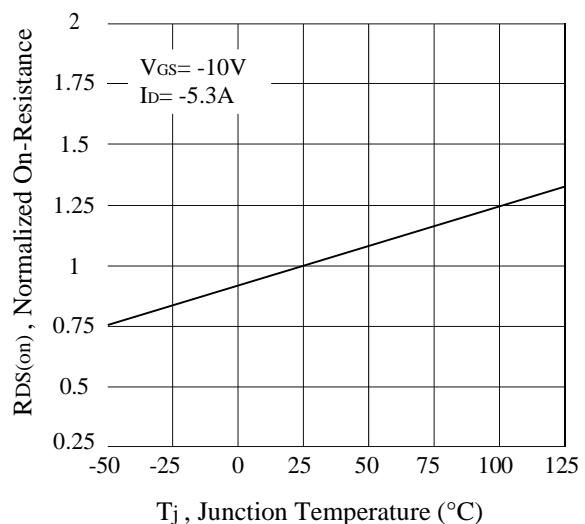


Figure 4. On-Resistance Variation with Temperature

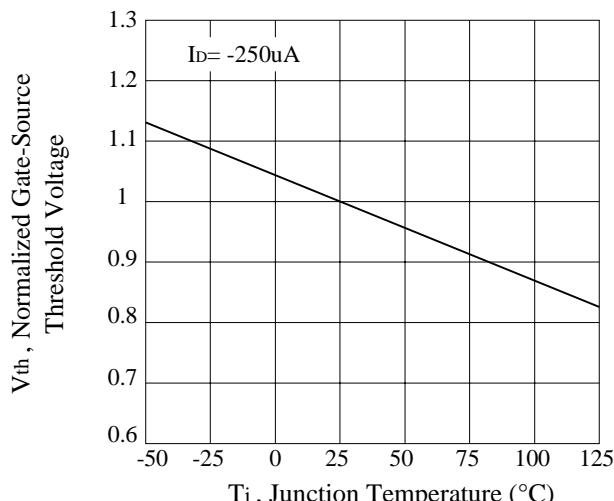


Figure 5. Gate Threshold Variation with Temperature

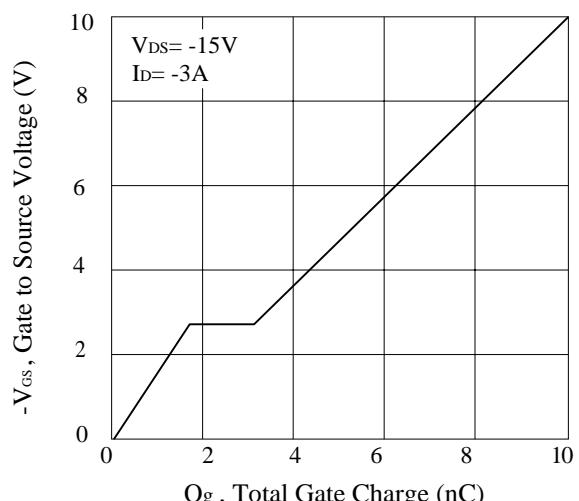
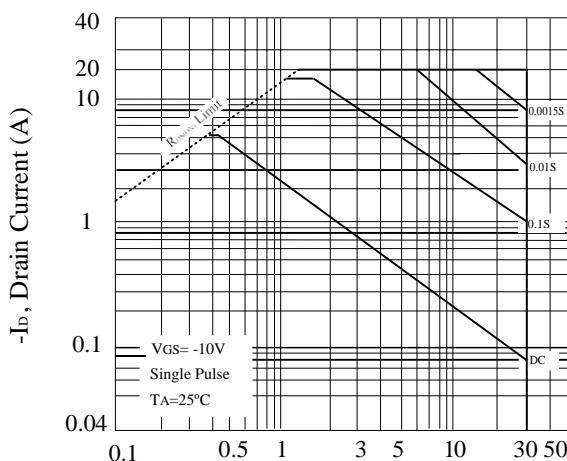
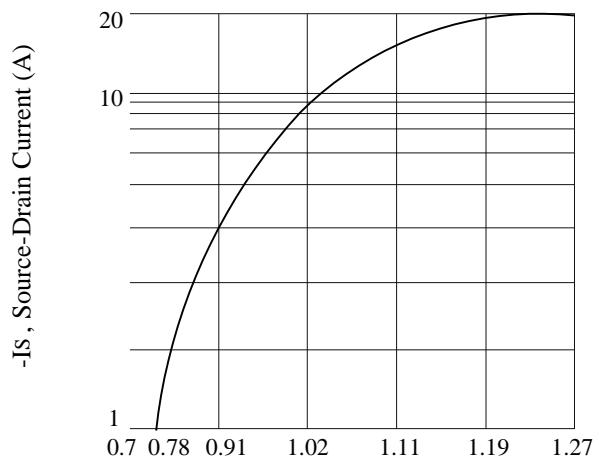


Figure 6. Gate Charge



-VDS , Drain-Source Voltage (V)
 Figure 7. Maximum Safe Operating
 Area



-VSD , Body Diode Forward Voltage (V)
 Figure 8. Body Diode Forward Voltage Variation
 with Source Current

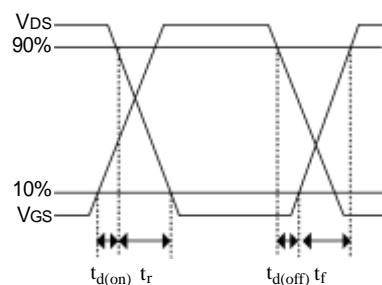
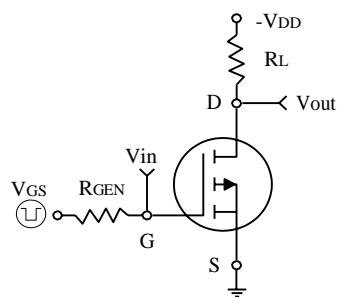


Figure 9. Switching Test Circuit and Switching
 Waveforms

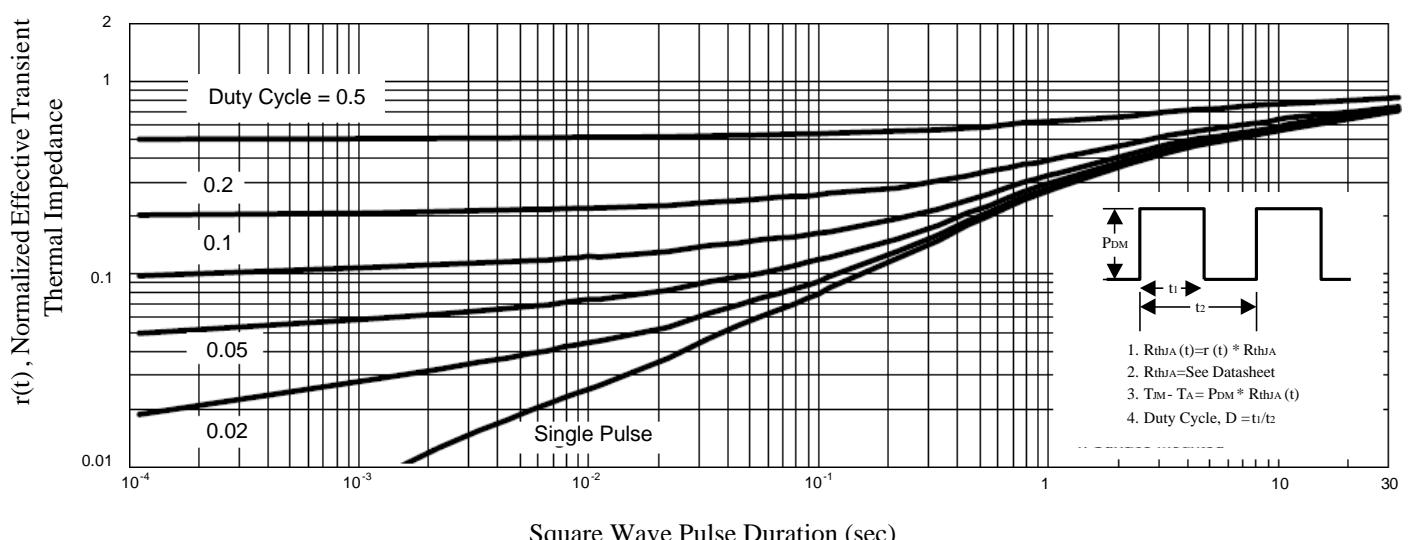


Figure 10. Normalized Thermal Transient Impedance Curve